

# 30V N-Channel Trench MOSFET(Preliminary)

## **General Description**

- Trench Power technology
- Low R<sub>DS(ON)</sub>
- Low Gate Charge
- Optimized for fast-switching applications

## **Applications**

- Synchronous Rectification in DC/DC and AC/DC Converters
- Isolated DC/DC Converters in Telecom and Industrial

### **Product Summary**

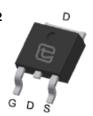
 $V_{DS}$  30V  $I_{D}$  (at  $V_{GS}$ =10V) 160A  $R_{DS(ON)}$  (at  $V_{GS}$ =10V) < 2.2m $\Omega$ 

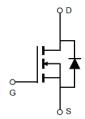
 $R_{DS(ON)}$  (at  $V_{GS}$ =4.5V) < 3m $\Omega$ 

100% UIS Tested









Part Number	Package Type	Form	Marking	
TTD160N03GT	TO-252	Tape&Reel	160N03GT	

## Absolute Maximum Ratings (T<sub>A</sub> =25°C unless otherwise noted)

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V <sub>DS</sub>	30	V	
Gate-Source Voltage		V <sub>GS</sub>	±20	V	
Continuous Drain Current B	T <sub>C</sub> =25°C		46	Δ.	
Continuous Drain Current B	T <sub>C</sub> =100°C	I <sub>D</sub>	46	А	
Pulsed Drain Current <sup>A</sup>		I <sub>DM</sub>	480	Α	
Avalanche Current A		I <sub>AS</sub>	43	А	
Single Pulse Avalanche Energy L =0.3mH A		E <sub>AS</sub>	277	mJ	
Power Dissipation <sup>C</sup>	T <sub>C</sub> =25°C	Б	143	W	
	T <sub>C</sub> =100°C	P <sub>D</sub>	71	W	
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 175	°C	

#### **Thermal Characteristics**

Parameter		Symbol	Maximum	Units	
Maximum Junction-to-Case	Steady-State	r-State R <sub>eJC</sub> 1.1		000	
Maximum Junction-to-Ambient	Steady-State	R <sub>OJA</sub>	100	°C/W	



Electric	Electrical Characteristics(T <sub>J</sub> =25°C unless otherwise noted)						
C: mala al	Doromotor	O a malistica and		Value			11
Symbol	Parameter Conditions			Min	Тур	Max	Units
STATIC P	ARAMETERS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		30			V
		T <sub>J</sub> =25°C			1	_	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current $V_{DS} = 30V, V_{GS} = 0V$	T <sub>J</sub> =100°C			25	μA	
I <sub>GSS</sub>	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	,			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		1	1.7	2.4	V
	Otatia Basia Ossasa On Basiatana	V <sub>GS</sub> =10V, I <sub>D</sub> =20A			1.7	2.2	mΩ
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A			2.3	3	mΩ
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =10V, I <sub>D</sub> =20A			34		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =10A, V <sub>GS</sub> =0V				1	V
I <sub>S</sub>	Maximum Body-Diode Continuous Curre	nt <sup>B</sup>				46	Α
DYNAMIC	PARAMETERS						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f =1MH <sub>Z</sub>			8313		
C <sub>oss</sub>	Output Capacitance				951		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				897		
SWITCHI	NG PARAMETERS						
Q <sub>g</sub> (10V)	Total Gate Charge	V <sub>GS</sub> =10V,V <sub>DS</sub> =15V, I <sub>D</sub> =50A			160		
$Q_{gs}$	Gate Source Charge				18		nC
$Q_{gd}$	Gate Drain Charge				34		
t <sub>D(on)</sub>	Turn-On Delay Time	$V_{GS} = 10V, V_{DS} = 15V, I_{D} = 50A,$ $R_{G} = 3\Omega$			27		
t <sub>r</sub>	Turn-On Rise Time				25		
$T_{D(off)}$	Turn-Off Delay Time				90		ns
t <sub>f</sub>	Turn-Off Fall Time				40		
t <sub>rr</sub>	Body Diode Reverse Recovery Time	1 200 4:/4+ 4000/			43		ns
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge				40		nC

- A. Single pulse width limited by maximum junction temperature.
- B. The maximum current rating is package limited.
- C. The power dissipation  $P_D$  is based on  $T_{J(MAX)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

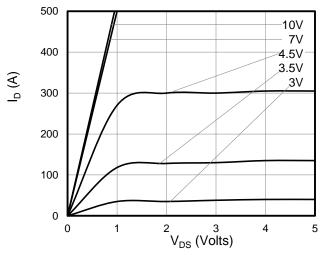
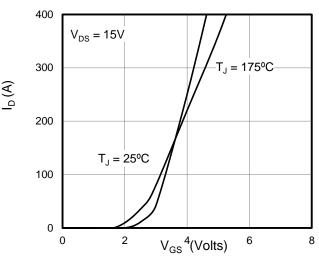


Figure 1: On-Region Characteristics



**Figure 2: Transfer Characteristics** 

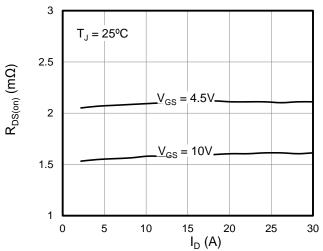


Figure 3: On-Resistance vs. Drain Current

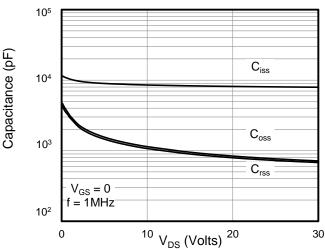


Figure 4: Capacitance Characteristics

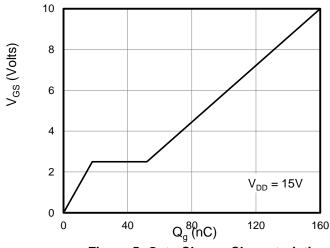


Figure 5: Gate Charge Characteristics

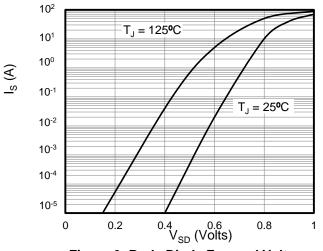
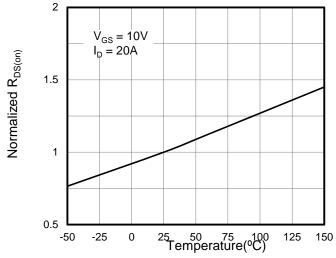


Figure 6: Body Diode Forward Voltage

 $Z_{\theta \ JC}$  Normalized Transient Thermal Resistance

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### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



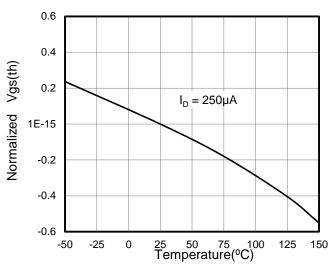
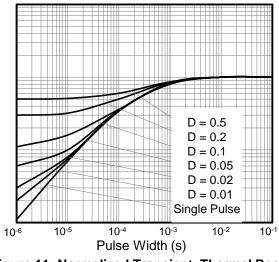


Figure 7: On-Resistance vs. Junction Temperature

Figure 8: Vgs(th) vs. Junction Temperature



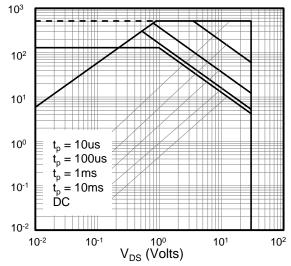


Figure 11: Normalized Transient Thermal Resistance

Figure 12: Safe Operating Area

I<sub>D</sub> (Amps)

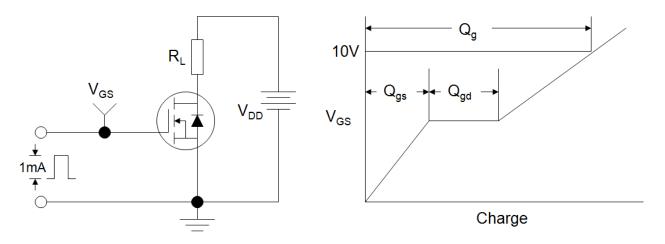


Figure A: Gate Charge Test Circuit and Waveforms

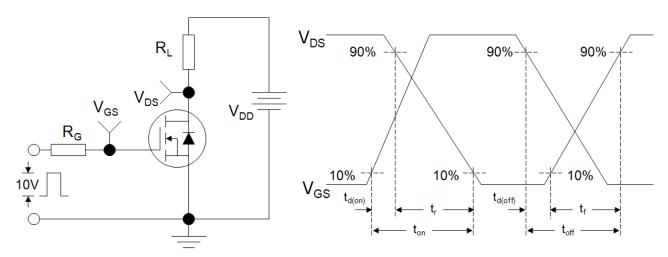


Figure B: Resistive Switching Test Circuit and Waveforms

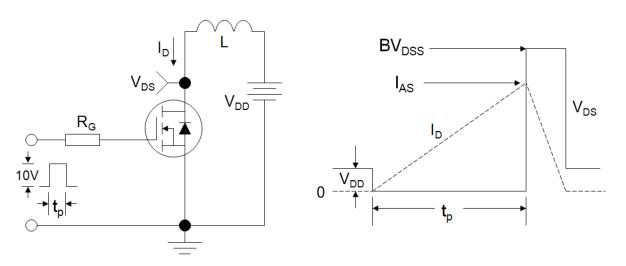
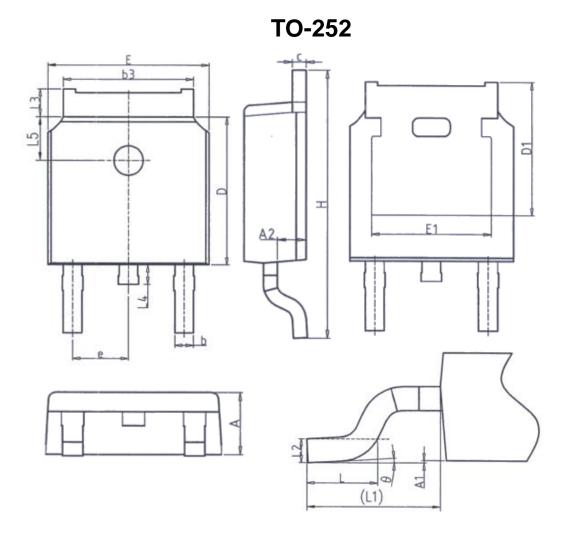


Figure C: Unclamped Inductive Switching (UIS) Test Circuit and Waveforms





Unit: mm				
Symbol	Min.	Max.		
Α	2. 20	2. 40		
A1	0.00	0. 20		
A2	0. 97	1. 17		
b	0. 68	0. 90		
b3	5. 20	5. 50		
С	0. 43	0. 63		
D	5. 98	6. 22		
D1	5. 30REF			
E	6. 40	6. 80		
<b>E</b> 1	4. 63	_		

Unit: mm				
Symbol	Min. Max.			
е	2. 286BSC			
Н	9. 40	10.50		
L	1. 38	1. 75		
L1	2. 90REF			
L2	0. 51BSC			
L3	0.88	1. 28		
L4	_	1.00		
L5	1. 65	1. 95		
θ	0°	8°		



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